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# Connector, Z-PACK\*, 8 Row, 2mm HM

### SCOPE 1.

### Content 1.1.

This specification covers performance, tests and quality requirements for the Z-PACK\* 8 row, 2mm HM connector system. These connectors are two-piece devices to interconnect 2 printed circuit boards. Receptacle and pin connectors are through hole devices with ACTION PIN\* contacts. Connectors are in 8 row configurations and can be upgraded to 10 row configuration.

### Qualification 1.2.

When tests are performed on subject product line, procedures specified in IEC 512 (see Figure 8) shall be used. All inspections shall be performed using applicable inspection plan and product drawing.

### APPLICABLE DOCUMENTS 2.

The following documents form a part of this specification to the extent specified herein. Unless otherwise specified, latest edition of the document applies. In the event of conflict between requirements of this specification and product drawing, product drawing shall take precedence. In the event of conflict between requirements of this specification and referenced documents, this specification shall take precedence.

### **AMP Documents** 2.1.

109-1: General Requirements for Test Specifications A.

Test Report

Test Specifications as indicated in Figure 1. (Comply with MIL-STD-202, MIL-109 Series: B.

STD-1344 and EIA RS-364)

Cross-reference between AMP Test Specifications and Military Corporate Bulletin 401-76: C.

or Commercial Documents

501-326:

### **Commercial Standards** 2.2.

IEC 512:

D

**Test Specification** 

### REQUIREMENTS 3.

### Design and Construction 3.1.

Product shall be of design, construction and physical dimensions specified on applicable product drawing.

### **Materials** 3.2.

Polyamide 35% GF, UL94HB Coding devices: A.

Phosphor bronze, gold over nickel plating in contact area Contact: B.

Thermoplastic polyester, 20% GF, UL94V-0 Housing: C.



# 3.3. Ratings

A. Voltage: 750 vrms contact to contact

B. Current: Signal application only, 1.5 amperes per contact at 70°C (fully loaded)

C. Temperature: -55 to 125°C

D. Air/creepage distance: 0.8mm minimum

# 3.4. Performance and Test Description

Product is designed to meet electrical, mechanical and environmental performance requirements specified in Figure 1. Unless otherwise specified, all tests shall be performed at ambient environmental conditions per IEC 512-1.

# 3.5. Test Requirements and Procedures Summary

Test Description	Requirement	Procedure			
Examination of product.	Meets requirements of product drawing.	IEC 512-2-1a. Visual, dimensional and functional per applicable quality inspection plan.			
	ELECTRICAL				
Termination resistance.	50 milliohms maximum initial. ΔR 5 milliohms maximum.	IEC 512-2-2a. Subject mated contacts assembled in housing to 20 mv maximum open circuit at 100 ma maximum. See Figure 3.			
Dielectric withstanding voltage.	750 vac at sea level.	IEC 512-2-4a, Method B. Test between 2 groups of alternate contacts of mated samples. Test between first group and second group connected to the housing or mounting plate. Then test between second group and first group connected to the housing or mounting plate. See Figure 4.			
Insulation resistance.	10000 megohms minimum initial. 1000 megohms minimum final.	IEC 512-2-3a, Method A. Test between each termination being tested and all others connected together, and between each termination being tested and the housing or mounting plate of mated samples.			
MECHANICAL					
Vibration, sinusoidal.	No discontinuities of 1 microsecond or longer duration. See Note (a).	IEC 512-4-6d. Subject mated samples to 10-500- 10 Hz traversed in 6.27 minutes. 5.66 hours in each of 3 mutually perpendicular planes. See Figure 5.			

Figure 1 (cont)



Test Description	Requirement	Procedure
Physical shock.	No discontinuities of 1 microsecond or longer duration. See Note (a).	IEC 512-4-6c. Subject mated samples to 50 G's half-sine shock pulses of 11 milliseconds duration. 5 shocks in each direction applied along 3 mutually perpendicular planes, 30 total shocks. See Figure 5.
Polarization force.	100 Newtons (22.48 pounds) minimum. See Note (a).	IEC 512-7-13e. Attempt to mate samples oriented 180° out of phase at maximum rate of 12.7mm (.5 inch) per minute.
Mating force.	.75 Newton (2.7 ounces) maximum per contact. See Note (a).	IEC 512-7-13e. Measure force necessary to mate samples at maximum rate of 12.7mm (.5 inch) per minute.
Unmating force.	.15 Newton (.5 ounce) minimum per contact. See Note (a).	IEC 512-7-13e. Measure force necessary to unmate samples at maximum rate of 12.7mm (.5 inch) per minute.
Contact retention force.	5 Newtons (1.1 pounds) minimum in mating direction. 10 Newtons (2.2 pounds) minimum in unmating direction. See Note (a).	IEC 512-8-15a. Subject 20% of contacts to axial load in both directions at maximum rate of 10 Newtons per second until specified load is reached and hold for 10 seconds.
Module retention force.	74 Newtons (16.62 pounds) minimum. See Note (a).	IEC 512-5-8a.  Measure force required to separate module from housing.  See Figure 6.
ACTION PIN contact retention force.	20 Newtons (4.49 pounds) minimum. See Note (a).	IEC 512-8-15a.  Measure force required to separate ACTION PIN from the printed circuit board.
Gage retention force.	15 grams (.53 ounce) minimum. See Note (a).	IEC 512-8-16e, Method A. Insert and remove a .381mm (.015 inch) gage 3 times. Then insert a .355mm (.014 inch) gage and measure force required to remove. See Figure 7.
Durability.	See Note (a).	IEC 512-5-9a.  Mate and unmate samples for 250 cycles at maximum rate of 600 cycles per hour.

Figure 1 (cont)



Test Description	Requirement	
		Procedure
	ENVIRONMENTAL	
Thermal shock.	See Note (a).	IEC 512-6-11d. Subject mated samples to 5 cycles between -55 and 125°C.
Humidity-temperature cycling.	See Note (a).	IEC 512-6-11c, 11j, and 11m. Subject mated samples to 6, 24 hour cycles between 25 and 40°C at 95% RH with -55°C cold shock.
Humidity, steady state.	See Note (a).	IEC 512-6-11c. Subject mated samples to steady state humidity of 93% and 40°C for 21 days.
Corrosion atmosphere.	See Note (a).	IEC 68-2-60. Subject mated and unmated samples to corrosion atmosphere for 4 days.
Temperature life and electrical load.	See Note (a).	IEC 512-6-11i. Subject mated samples to temperature life at 87.5°C for 1000 hours while energized with 1.25 amperes dc.

Note: (a) Shall meet visual requirements, show no physical damage and shall meet requirements of additional tests as specified in Test Sequence in Figure 2.

Figure 1 (end)



# **Product Qualification and Requalification Test Sequence** 3.6.

	Test Group (a)					
Test or Examination	1	2	3	4	5	6
Test of Examination	Test Sequence (b)					
Examination of product	1,19	1,14	1,11	1,10	1.3	1,5
Termination resistance	2,16	2,8,10	2,8	2,7		<u> </u>
Dielectric withstanding voltage	4,12,15	4,12	4,7	4,9		<u> </u>
nsulation resistance	3,11,14	3,11	3,6	3,8		ļ
Vibration	8					
Physical shock	9			<u> </u>		<del> </del>
Polarization force				<u> </u>		2
Mating force	5,17		9	<del> </del> _	<u> </u>	<del> </del>
Unmating force	6,18		10	<del> </del>		<del> </del>
Contact retention force				<u> </u>	<del> </del>	4
Module retention force				<u> </u>	<del> </del>	3
ACTION PIN contact retention force					2	<del> </del>
Gage retention force	7	5,13		<u> </u>	<u> </u>	
Durability		6,9	<u> </u>	5	<del> </del>	<del> </del>
Thermal shock	10		<u> </u>		<del> </del>	
Humidity-temperature cycling	13				<del> </del>	
Humidity, steady state			5			
Corrosion atmosphere		7				
Temperature life & electrical load				6	<u> </u>	

Note:

- See Para 4.1.A. (a)
- Numbers indicate sequence in which tests are performed. (b)

Figure 2

### QUALITY ASSURANCE PROVISIONS 4.

### **Qualification Testing** 4.1.

### Sample Selection A.

Samples shall be prepared in accordance with applicable Instruction Sheets and shall be selected at random from current production. Test groups 1, 2, 3, 4, and 5 shall each consist of 3, 200 position male assemblies and 4, 200 position female assemblies. Test group 6 shall consist of 4, 176 position male assemblies and 4, 176 position female assemblies.

### **Test Sequence** В.

Qualification inspection shall be verified by testing samples as specified in Figure 2.



### Requalification Testing 4.2.

If changes significantly affecting form, fit or function are made to product or manufacturing process, product assurance shall coordinate requalification testing, consisting of all or part of original testing sequence as determined by development/product, quality and reliability engineering.

### Acceptance 4.3.

Acceptance is based on verification that product meets requirements of Figure 1. Failures attributed to equipment, test setup or operator deficiencies shall not disqualify product. When product failure occurs, corrective action shall be taken and samples resubmitted for qualification. Testing to confirm corrective action is required before resubmittal.

## **Quality Conformance Inspection** 4.4.

Applicable AMP quality inspection plan will specify sampling acceptable quality level to be used. Dimensional and functional requirements shall be in accordance with applicable product drawing and this specification.

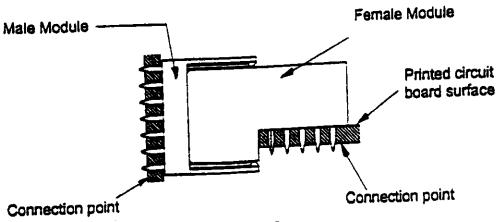


Figure 3 Termination Resistance Measurement Points



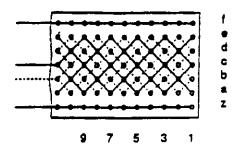


Figure 4
Dielectric Withstanding Voltage Wiring Arrangement

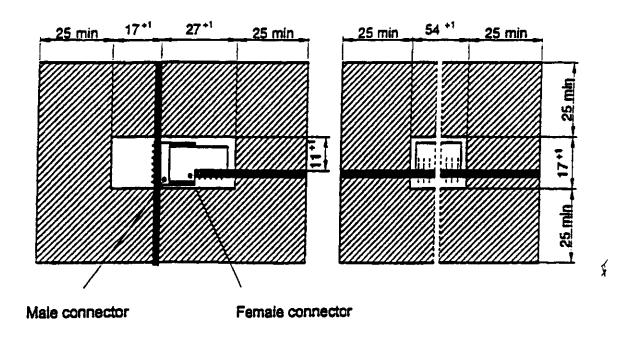


Figure 5
Vibration & Physical Shock Mounting Fixture



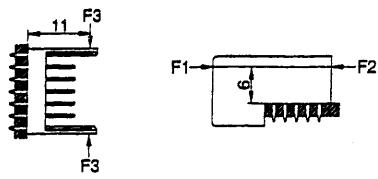
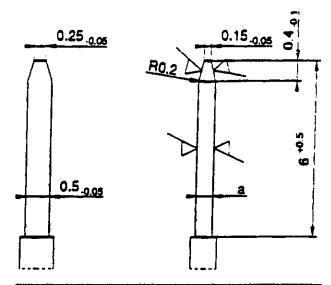


Figure 6 Module Retention Force



Application	"A" Dimension	Mass (grams)
Sizing	0.04 to 0.39	-
Retention Force	0.36 to 0.35	16 to 15

Figure 7
Gage Retention Force



Took	AMP Test Specification	IEC Specification
Test	7	512-2-1a
Examination of product	109-6-6, Condition F	512-2-2a
Termination resistance	109-29-1	512-2-4a, Method B
Dielectric withstanding voltage		512-2-3a, Method A
Insulation resistance	109-28-3, Condition C	512-4-6d
Vibration	109-21-2, Condition B	512-4-6c
Physical Shock	109-26-1	512-7-13e
Polarization force	109-42, Condition A	512-7-13a
Mating force	109-42, Condition A	
Unmating force	109-42, Condition A	512-7-13a
Contact retention force	109-30	512-8-15a
Module retention force	109-30	512-5-8a
ACTION PIN contact retention force	109-30	512-8-15a
	109-30	512-8-16e, Method A
Gage retention force	109-27	512-5-9a
Durability	109-22	512-6-11d
Thermal shock	109-23-3	512-6-11c, 11j , 11m
Humidity-temperature cycling	109-23-2	512-6-11c
Humidity, steady state	109-85	68-2-60
Corrosion atmosphere	109-43	512-6-11i
Temperature life & electrical load	109-43	

Figure 8

Qualification Test Cross Reference